1. Record Nr. UNINA9911018946503321 Autore Ruterana Pierre Titolo Nitride semiconductors: handbook on materials and devices // Pierre Ruterana, Martin Albrecht, Jorg Neugebauer Weinheim;; [Great Britain],: Wiley-VCH, c2003 Pubbl/distr/stampa **ISBN** 9786610854370 9781280854378 1280854375 9783527607402 3527607404 9783527607648 3527607641 9781601192820 1601192827 Descrizione fisica 1 online resource (688 p.) Altri autori (Persone) AlbrechtMartin NeugebauerJorg Disciplina 537.622 621.3815/2 621.38152 Soggetti **Nitrides** Semiconductors - Materials Lingua di pubblicazione Inglese **Formato** Materiale a stampa Livello bibliografico Monografia Note generali Description based upon print version of record. Includes bibliographical references and index. Nota di bibliografia Nota di contenuto Nitride Semiconductors Handbook on Materials and Devices: Contents: Preface: List of Contributors: Part 1 Material: 1 High-Pressure Crystallization of GaN; 1.1 Introduction; 1.2 High-Pressure Crystallization of GaN; 1.2.1 Thermodynamics - Properties of GaN-Ga-N(2) System; 1.2.2 Dissolution Kinetics of N(2) and Crystal Growth Mechanism; 1.2.3 What Happens with GaN at High Temperature when

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Sommario/riassunto

Semiconductor components based on silicon have been used in a wide range of applications for some time now. These elemental semiconductors are now well researched and technologically well developed. In the meantime the focus has switched to a new group of materials: ceramic semiconductors based on nitrides are currently the subject of research due to their optical and electronic characteristics. They open up new industrial possibilities in the field of photosensors, as light sources or as electronic components. This collection of review articles provides a systematic and in-depth overview o